

INTERNATIONAL STANDARD



**Connectors for electrical and electronic equipment – Product requirements –
Part 3-122: Detail specification for 8-way, shielded, free and fixed connectors for
I/O and Gigabit Ethernet applications in harsh environments**

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**CONNECTORS FOR ELECTRICAL AND ELECTRONIC EQUIPMENT –
PRODUCT REQUIREMENTS –****Part 3-122: Detail specification for 8-way, shielded, free and fixed
connectors for I/O and Gigabit Ethernet applications
in harsh environments**

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International Standard IEC 61076-3-122 has been prepared by subcommittee 48B: Electrical connectors, of IEC technical committee 48: Electrical connectors and mechanical structures for electrical and electronic equipment.

This first edition cancels and replaces IEC PAS 61076-3-122 published in 2015. This edition constitutes a technical revision.

The text of this International Standard is based on the following documents:

| | |
|---------------|------------------|
| FDIS | Report on voting |
| 48B/2554/FDIS | 48B/2563/RVD |

Full information on the voting for the approval of this International Standard can be found in the report on voting indicated in the above table.

This document has been drafted in accordance with the ISO/IEC Directives, Part 2.

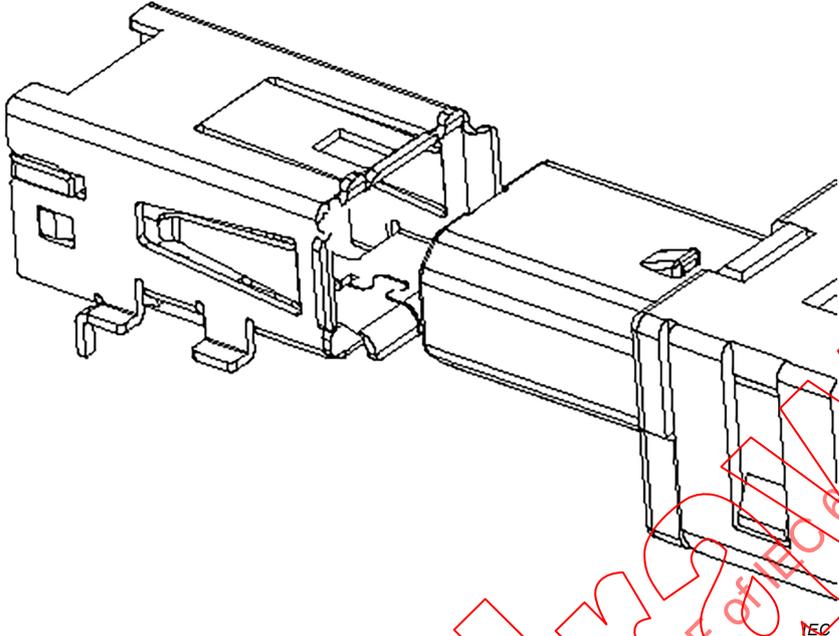
A list of all parts in the IEC 61076 series, published under the general title *Connectors for electronic equipment – Product requirements*, can be found on the IEC website.

The committee has decided that the contents of this document will remain unchanged until the stability date indicated on the IEC website under "<http://webstore.iec.ch>" in the data related to the specific document. At this date, the document will be

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| | |
|---|---|
| | IEC 61076-3-122:2017 |
| Subcommittee 48B: Electrical connectors | |
|  <p>The image shows a technical drawing of two electrical connectors. On the left is a 'free connector' with a rectangular body and a central opening. On the right is a 'fixed connector' with a similar body but with a different internal structure. Both have coding edges. A large red watermark 'IECNORM.COM' is overlaid diagonally across the image.</p> | <p>Detail specification for 8-way, shielded, free and fixed connectors for I/O and Gigabit Ethernet applications in harsh environments</p> |
| <p>NOTE The above view shows a Type I connector pair, with coding edges on a short side; for Type II connectors the coding edges are located on a long side.</p> | <p>Fixed connectors are mounted on printed circuit board by means of soldering or press-in, the free connector is attached to wires by means of soldering, crimping, IDC or other termination technology.</p> |

CONNECTORS FOR ELECTRICAL AND ELECTRONIC EQUIPMENT – PRODUCT REQUIREMENTS –

Part 3-122: Detail specification for 8-way, shielded, free and fixed connectors for I/O and Gigabit Ethernet applications in harsh environments

1 Scope

This part of IEC 61076 covers 8-way, shielded, free and fixed rectangular connectors for I/O and Gigabit Ethernet applications, suitable for use in harsh environments, and is intended to specify the common dimensions, mechanical, electrical and environmental characteristics and tests for this family of connectors.

2 Normative references

The following documents are referred to in the text in such a way that some or all of their content constitutes requirements of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

IEC 60050-581, *International Electrotechnical Vocabulary (IEV) – Chapter 581: Electromechanical components for electronic equipment*

IEC 60068-1, *Environmental testing – Part 1: General and guidance*

IEC 60068-2-38, *Environmental testing – Part 2-38: Tests – Test Z/AD: Composite temperature/humidity cyclic test*

IEC 60512-1, *Connectors for electronic equipment – Tests and measurements – Part 1: General*

IEC 60512-1-1, *Connectors for electronic equipment – Tests and measurements – Part 1-1: General examination – Test 1a: Visual examination*

IEC 60512-1-2, *Connectors for electronic equipment – Tests and measurements – Part 1-2: General examination – Test 1b: Examination of dimension and mass*

IEC 60512-2-1, *Connectors for electronic equipment – Tests and measurements – Part 2-1: Electrical continuity and contact resistance tests – Test 2a: Contact resistance – Millivolt level method*

IEC 60512-3-1, *Connectors for electronic equipment – Tests and measurements – Part 3-1: Insulation tests – Test 3a: Insulation resistance*

IEC 60512-4-1, *Connectors for electronic equipment – Tests and measurements – Part 4-1: Voltage stress tests – Test 4a: Voltage proof*

IEC 60512-5-2, *Connectors for electronic equipment – Tests and measurements – Part 5-2: Current-carrying capacity tests – Test 5b: Current-temperature derating*

IEC 60512-6-3, *Connectors for electronic equipment – Tests and measurements – Part 6-3: Dynamic stress tests – Test 6c: Shock*

IEC 60512-6-4, *Connectors for electronic equipment – Tests and measurements – Part 6-4: Dynamic stress tests – Test 6d: Vibration (sinusoidal)*

IEC 60512-9-1, *Connectors for electronic equipment – Tests and measurements – Part 9-1: Endurance tests – Test 9a: Mechanical operation*

IEC 60512-11-3, *Connectors for electronic equipment – Tests and measurements – Part 11-3: Climatic tests – Test 11c: Damp heat, steady state*

IEC 60512-11-4, *Connectors for electronic equipment – Tests and measurements – Part 11-4: Climatic tests – Test 11d: Rapid change of temperature*

IEC 60512-11-7, *Connectors for electronic equipment – Tests and measurements – Part 11-7: Climatic tests – Test 11g: Flowing mixed gas corrosion test*

IEC 60512-11-9, *Connectors for electronic equipment – Tests and measurements – Part 11-9: Climatic tests – Test 11i: Dry heat*

IEC 60512-11-10, *Connectors for electronic equipment – Tests and measurements – Part 11-10: Climatic tests – Test 11j: Cold*

IEC 60512-13-2, *Connectors for electronic equipment – Tests and measurements – Part 13-2: Mechanical operation tests – Test 13b: Insertion and withdrawal forces*

IEC 60512-15-6, *Connectors for electronic equipment – Tests and measurements – Part 15-6: Connector tests (mechanical) – Test 15f: Effectiveness of connector coupling devices*

IEC 60512-26-100, *Connectors for electronic equipment – Tests and measurements – Part 26-100: Measurement setup, test and reference arrangements and measurements for connectors according to IEC 60603-7 – Tests 26a to 26g*

IEC 61076-1:2006, *Connectors for electronic equipment – Product requirements – Part 1: Generic specification*

IEC 61076-3, *Connectors for electronic equipment – Product requirements – Part 3: Rectangular connectors – Sectional specification*

3 Terms and definitions

For the purposes of this document, the terms and definitions given in IEC 60050-581, IEC 61076-1, IEC 61076-3 and IEC 60512-1 apply.

ISO and IEC maintain terminological databases for use in standardization at the following addresses:

- IEC Electropedia: available at <http://www.electropedia.org/>
- ISO Online browsing platform: available at <http://www.iso.org/obp>

4 Mating information

4.1 General

Dimensions are given in millimetres. Drawings are shown in third-angle projection. The shape of connectors may deviate from those given in Figures 1 to 6 and Tables 1 to 5 as long as the specified dimensions are not changed.

4.2 Contacts – mating conditions

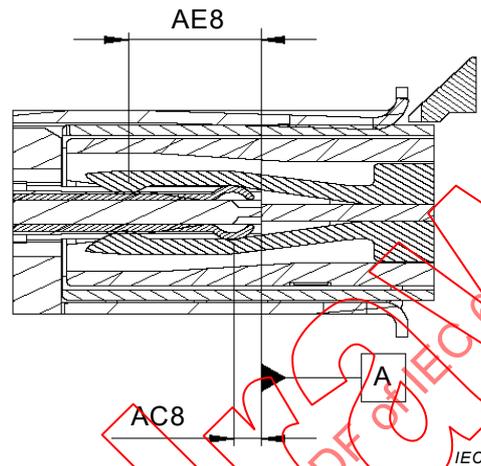


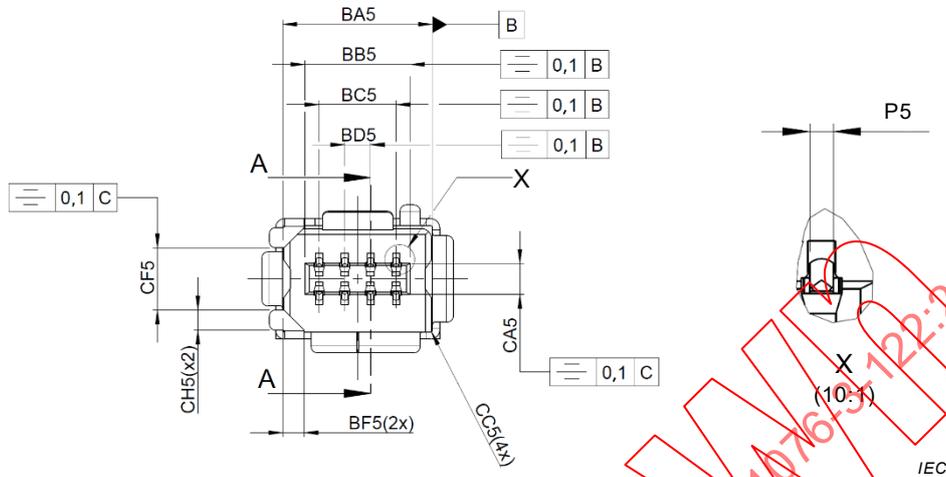
Figure 1 – Contact interface dimensions with a free (male) connector (right side) mated with a fixed (female) connector (left side)

Table 1 – Dimensions for Figure 1

| Dimension designation | Minimum | Nominal | Maximum |
|-----------------------|---------|---------|---------|
| AC8 | 0,7 | 0,8 | 0,9 |
| AE8 | 3,7 | 3,8 | 3,9 |

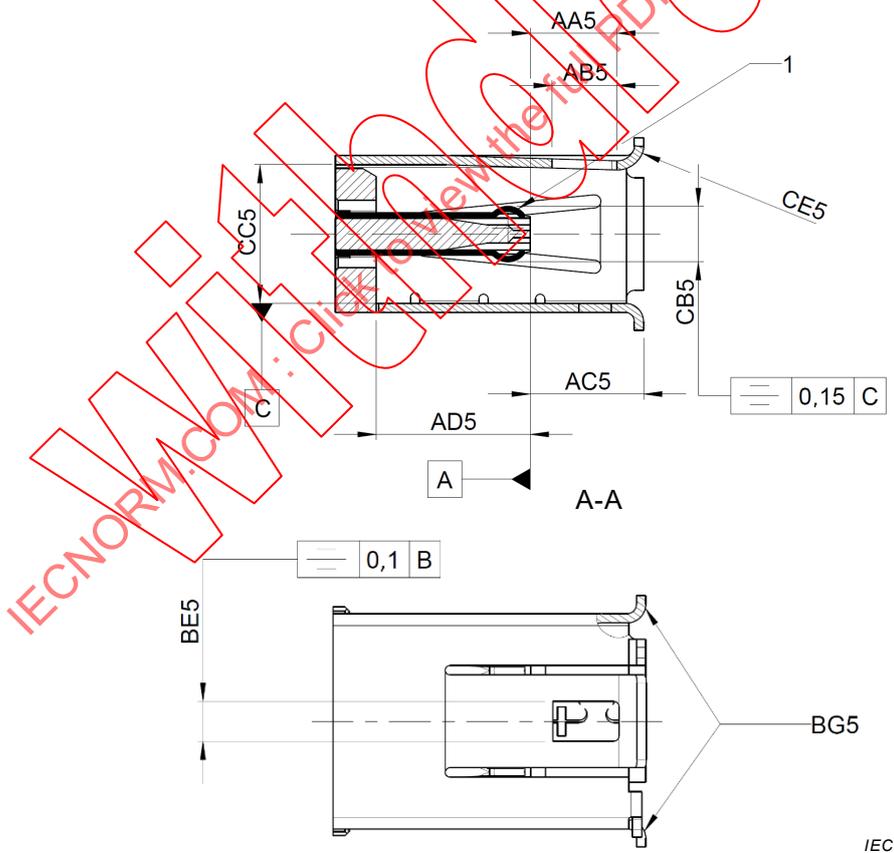
4.3 Fixed connector Type I

(Dimensions in millimetres)



Detail A: contacts shall be located within their individual contact zone in the indicated area P5.
Section A-A: see Figure 3.

Figure 2a – Fixed female connector Type I – mating side view



NOTE Preferred free connector stop surface.

Figure 2b – Fixed (female) connector – section A-A with top view

Figure 2 – Fixed female connector Type I

Table 2 – Dimensions for Figure 2

(Dimensions in millimetres)

| Dimension designation | Minimum | Nominal | Maximum |
|-----------------------|---------|---------|---------|
| AA5 | 3,1 | 3,2 | 3,3 |
| AB5 | 2,3 | 2,4 | 2,5 |
| AC5 | 4,2 | 4,3 | 4,4 |
| AD5 | 5,7 | 5,8 | 5,9 |
| | | | |
| BA5 | 7,35 | 7,4 | 7,5 |
| BB5 | 5,1 | 5,2 | 5,3 |
| BC5 | 3,88 | 3,9 | 3,95 |
| BD5 | 1,15 | 1,2 | 1,3 |
| BE5 | 1,4 | 1,5 | 1,6 |
| BF5 | 0,95 | 1,05 | 1,1 |
| BG5 | R 0,65 | R 0,7 | R 0,75 |
| | | | |
| CA5 | 1,45 | 1,5 | 1,55 |
| CB5 | 2 | 2,1 | 2,2 |
| CC5 | 5,25 | 5,3 | 5,35 |
| CE5 | R 0,9 | R 1,0 | R 1,05 |
| CD5 | 1,05 | 1,1 | 1,15 |
| CF5 | 3 | 3,1 | 3,2 |
| | | | |
| P5 | 0,25 | 0,3 | 0,35 |

4.4 Free connector Type I

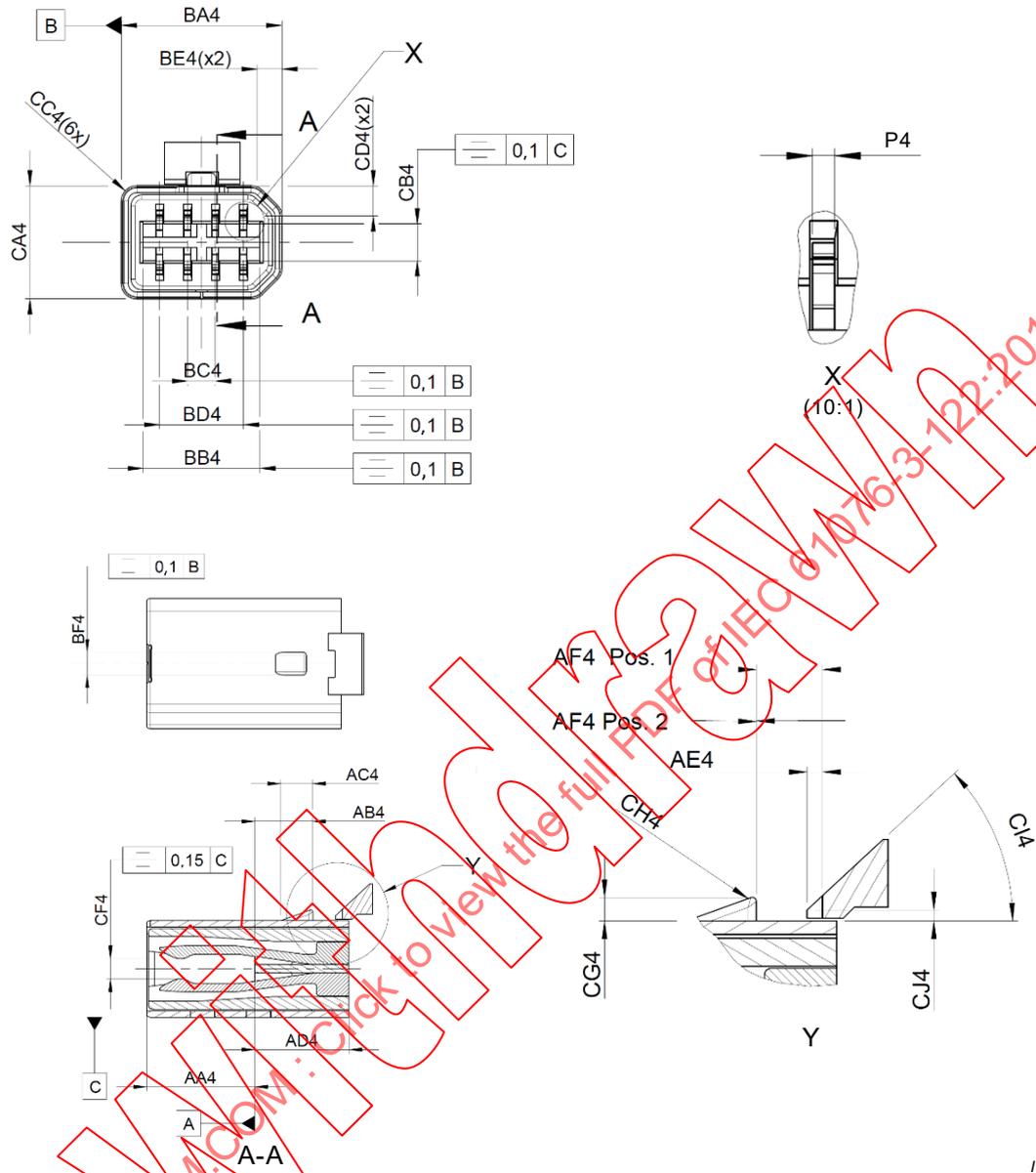


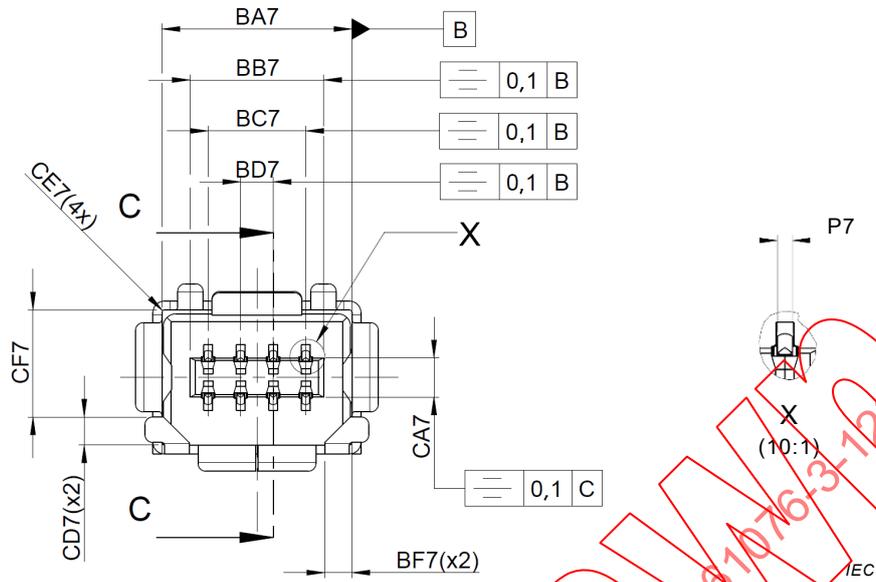
Figure 3 – Free male connector Type I

Table 3 – Dimensions for Figure 3

(Dimensions in millimetres)

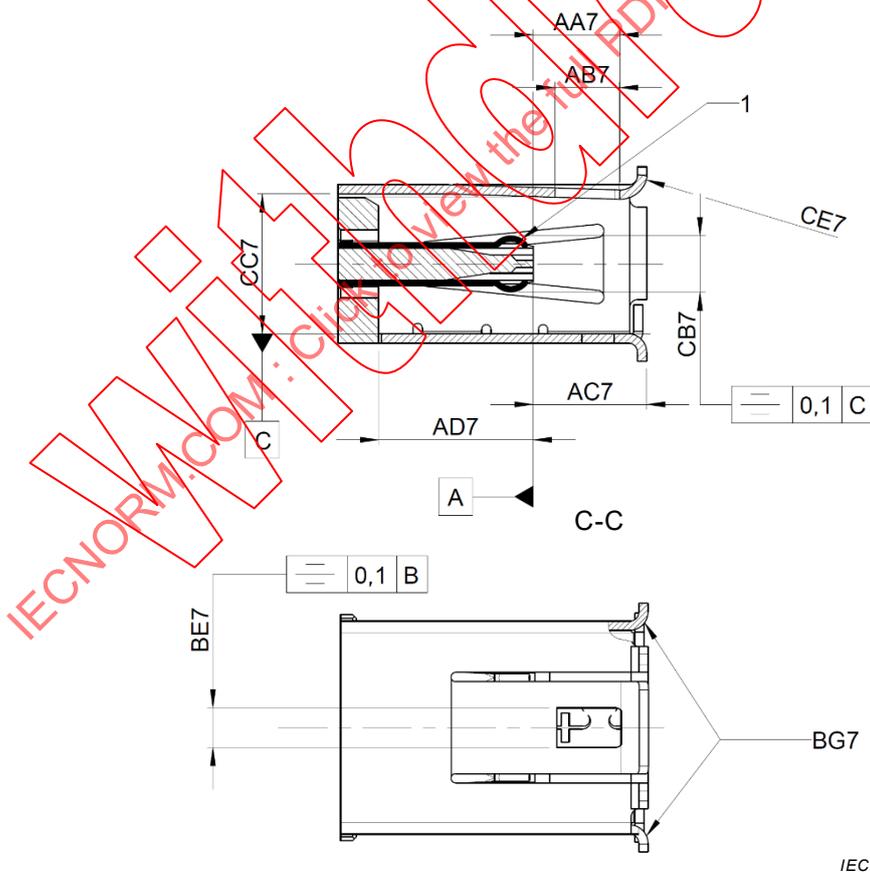
| Dimension designation | Minimum | Nominal | Maximum |
|-----------------------|---------|---------|---------|
| AA4 | 5,7 | 5,8 | 5,9 |
| AB4 | 2,9 | 3 | 3,1 |
| AC4 | 1,6 | 1,7 | 1,8 |
| AD4 | 4,9 | 5 | 5,1 |
| AE4 | 0,25 | 0,35 | 0,35 |
| AF4 pos. 1 | 1,6 | 1,65 | 1,7 |
| AF4 pos. 2 | 0 | 0,05 | 0,1 |
| CA4 | 5,15 | 5,1 | 5,23 |
| CB4 | 1,65 | 1,7 | 1,7 |
| CC4 | R 0,65 | R 0,7 | R 0,7 |
| CD4 | 1,25 | 1,3 | 1,4 |
| CF4 | 1 | 1 | 1,1 |
| CG4 | 0,45 | 0,5 | 0,55 |
| CH4 | R 0,05 | R 0,1 | R 0,15 |
| CI4 | 41° | 43° | 45° |
| CJ4 | 0,17 | 0,2 | 0,25 |
| BA4 | 7,24 | 7,3 | 7,34 |
| BB4 | 5,27 | 5,3 | 5,33 |
| BC4 | 1,22 | 1,27 | 1,3 |
| BD4 | 3,7 | 3,8 | 3,9 |
| BE4 | 1,07 | 1,1 | 1,13 |
| BF4 | 1,2 | 1,3 | 1,4 |
| P4 | 0,25 | 0,3 | 0,35 |

4.5 Fixed connector Type II



Contact zone: Contacts shall be completely within their individual contact zone in the indicated area P7.

Figure 4a – Fixed (female) connector Type II – mating side view



NOTE Preferred free connector stop surface.

Figure 4b – Fixed (female) connector Type II – Section C-C with top view

Figure 4 – Fixed (female) connector Type II

Table 4 – Dimensions for Figure 4

(Dimensions in millimetres)

| Dimension designation | Minimum | Nominal | Maximum |
|-----------------------|---------|---------|---------|
| AA7 | 3,1 | 3,2 | 3,3 |
| AB7 | 2,3 | 2,4 | 2,5 |
| AC7 | 4,2 | 4,3 | 4,4 |
| AD7 | 5,7 | 5,8 | 5,9 |
| | | | |
| BA7 | 7,35 | 7,4 | 7,5 |
| BB7 | 5,1 | 5,2 | 5,3 |
| BC7 | 3,88 | 3,9 | 3,95 |
| BD7 | 1,15 | 1,2 | 1,3 |
| BE7 | 1,4 | 1,5 | 1,6 |
| BF7 | 0,95 | 1,1 | 1,05 |
| BG7 | R 0,65 | R 0,7 | R 0,75 |
| | | | |
| CA7 | 1,45 | 1,5 | 1,55 |
| CB7 | 2 | 2,1 | 2,2 |
| CC7 | 5,25 | 5,3 | 5,35 |
| CE7 | R 0,9 | R 1,0 | R 1,05 |
| CD7 | 1,05 | 1,1 | 1,15 |
| CF7 | 4,1 | 4,2 | 4,3 |
| | | | |
| P7 | 0,25 | 0,3 | 0,35 |

4.6 Free connector Type II

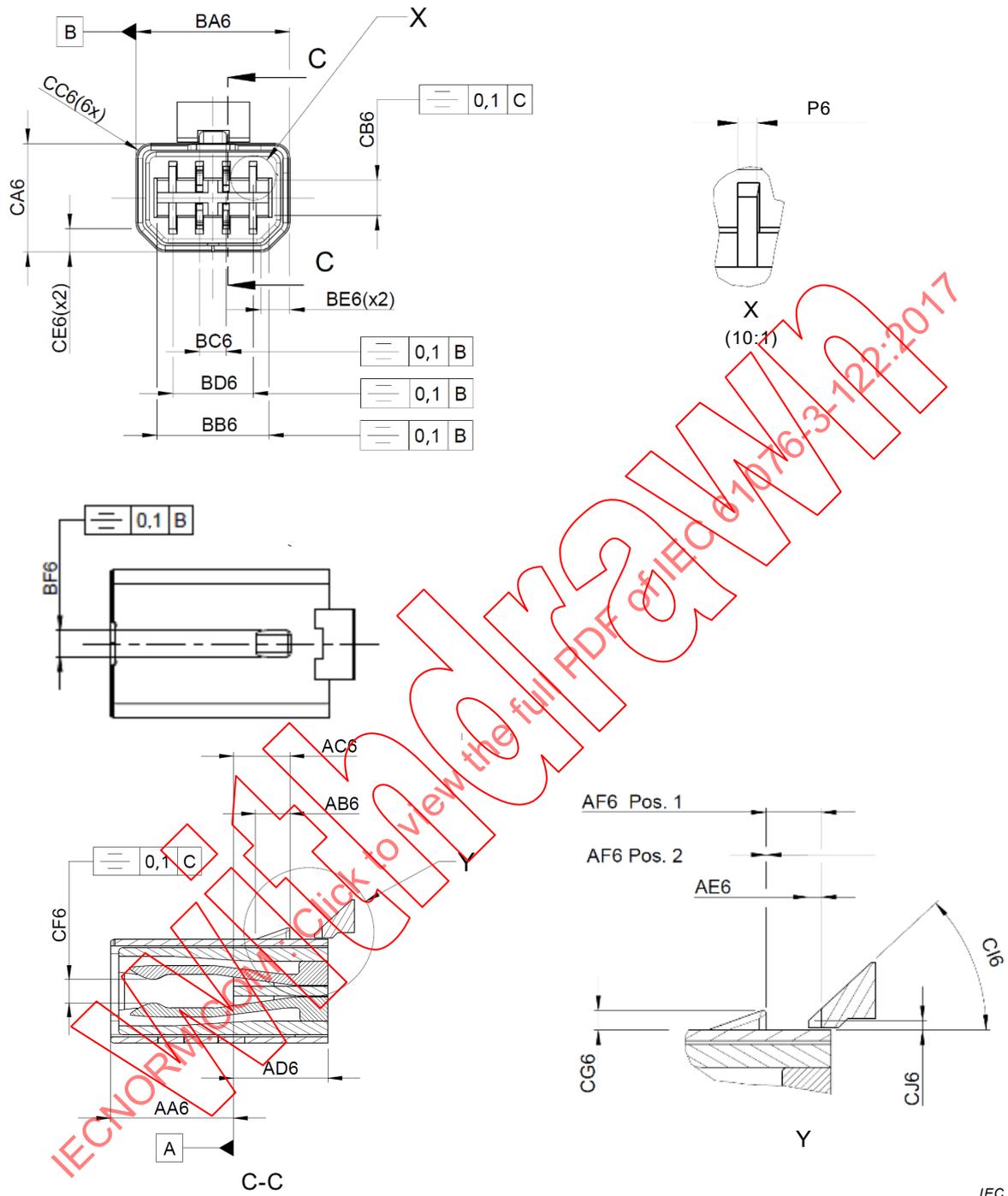


Figure 5 – Free (male) connector Type II

Table 5 – Dimensions for Figure 5

(Dimensions in millimetres)

| Dimension designation | Minimum | Nominal | Maximum |
|-----------------------|---------|---------|---------|
| AA6 | 5,7 | 5,8 | 5,9 |
| AB6 | 2,9 | 3 | 3,1 |
| AC6 | 1,6 | 1,7 | 1,8 |
| AD6 | 4,9 | 5 | 5,1 |
| AE6 | 0,25 | 0,3 | 0,35 |
| AF6 pos. 1 (unmated) | 1,6 | 1,65 | 1,7 |
| AF6 pos. 2 (mated) | 0 | 0,05 | 0,1 |
| CA6 | 5,15 | 5,2 | 5,23 |
| CB6 | 1,65 | 1,7 | 1,7 |
| CC6 | R 0,65 | R 0,7 | R 0,7 |
| CD6 | 1,25 | 1,3 | 1,4 |
| CE6 | 1 | 1,1 | 1,2 |
| CF6 | 1 | 1 | 1,1 |
| CG6 | 0,45 | 0,5 | 0,55 |
| CH6 | R 0,05 | R 0,1 | R 0,15 |
| CI6 | 41° | 43° | 45° |
| CJ6 | 0,17 | 0,2 | 0,25 |
| | | | |
| BA6 | 7,24 | 7,3 | 7,34 |
| BB6 | 5,27 | 5,3 | 5,33 |
| BC6 | 1,22 | 1,27 | 1,3 |
| BD6 | 3,7 | 3,8 | 3,9 |
| BE6 | 1,07 | 1,1 | 1,13 |
| BF6 | 1,2 | 1,3 | 1,4 |
| | | | |
| P6 | 0,25 | 0,3 | 0,35 |

5 Characteristics

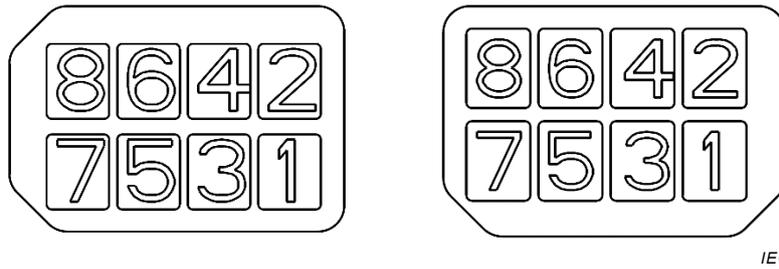
5.1 General

Compliance to the test schedules is intended to ensure the reliability of all performance parameters, over the range of operating climatic conditions. Stable and compliant contact resistance is a good indication of the stability of transmission performance.

5.2 Pin and pair grouping assignment

For those specifications where pin and pair groupings are relevant, the pin and pair grouping assignments shall be as shown in Figure 7, unless otherwise specified.

Board connector pin location, see Figure 6.



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Figure 6 – Fixed connector pin and pair grouping assignment for Type I (left, with coding edges on one short side) and Type II (right, with coding edges on one long side), front view of connector

For the board connector pin assignment for 10/100 Mb Ethernet applications, see Table 6. For the board connector pin assignment for 1 Gb Ethernet applications, see Table 7.

Table 6 – Pin assignment for 10/100 Mb Ethernet

| Pin No. | Signal | Function |
|---------|--------|-----------------|
| 1 | TXD_P | Transmit Data + |
| 2 | TXD_N | Transmit Data – |
| 3 | RXD_P | Receive Data + |
| 4 | N.C. | Not connected |
| 5 | N.C. | Not connected |
| 6 | RXD_N | Receive Data – |
| 7 | N.C. | Not connected |
| 8 | N.C. | Not connected |

Table 7 – Pin assignment for 1 Gb Ethernet

| Pin No. | Signal | Function |
|---------|---------|--|
| 1 | BI_DA_P | 1000Base-T signal, Bi-directional pair A + |
| 2 | BI_DA_N | 1000Base-T signal, Bi-directional pair A – |
| 3 | BI_DB_P | 1000Base-T signal, Bi-directional pair B + |
| 4 | BI_DC_P | 1000Base-T signal, Bi-directional pair C + |
| 5 | BI_DC_N | 1000Base-T signal, Bi-directional pair A – |
| 6 | BI_DB_N | 1000Base-T signal, Bi-directional pair B – |
| 7 | BI_DD_P | 1000Base-T signal, Bi-directional pair D + |
| 8 | BI_DD_N | 1000Base-T signal, Bi-directional pair D – |

5.3 Classification into climatic category

The lowest and highest temperatures and the duration of the damp-heat steady-state test shall be selected from the preferred values stated in 2.3 of IEC 61076-1:2006. The connectors are classified into climatic categories in accordance with the general rules given in IEC 60068-1. The temperature range and severity of the damp heat, steady state test are given in Table 8.

Table 8 – Climatic category

| Climatic category | Lower temperature °C | Upper temperature °C | Damp heat, steady state days |
|--------------------------|--------------------------------|--------------------------------|--|
| -55/85/21 | -55 | 85 | 21 |

5.4 Electrical characteristics

5.4.1 Voltage proof

Conditions: IEC 60512-4-1, Test 4a, Standard atmospheric conditions

Mated connectors

All variants: 500 V d.c.; one contact to all other contacts connected together.
2 250 V d.c.; between bridged signal contacts on plug and board side and earth shield.

5.4.2 Voltage rating

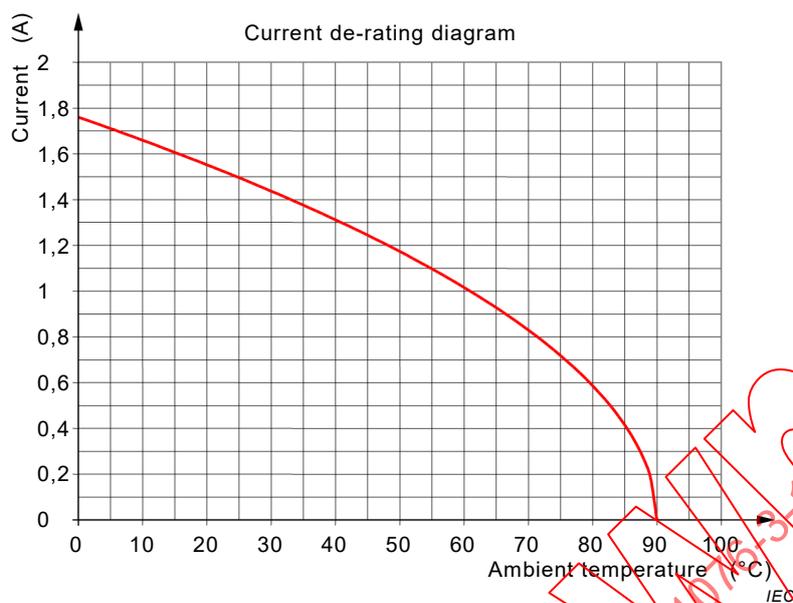
Signal connectors, intended for a voltage up to and including 50 V a.c./ 120 V d.c.

5.4.3 Current-temperature derating

Conditions: IEC 60512-5-2, Test 5b

All contacts, connected in series with the relevant contacts of the fixed connector are connected with each other on the PCB, and where the free connector is terminated on wires with the highest possible cross-section.

The current-carrying capacity of connectors in accordance with the requirements of 2.5 of IEC 61076-1:2006 shall comply with the de-rating curve given in Figure 7.



NOTE 1 The maximum permissible current for a given ambient temperature (t) is: $I_{(t)} = 1,76 \cdot \left(1 - \frac{t}{90}\right)^{0,5}$

NOTE 2 For ambient temperatures lower than 0 °C, the maximum permissible current per conductor is 1,76 A.

Figure 7 – Connector de-rating curve

5.4.4 Initial insulation resistance

Conditions: IEC 60512-3-1, Test 3a
 Method A
 Mated connectors
 Test voltage: 500 V d.c.
 All types: 500 MΩ minimum

5.5 Mechanical characteristics

5.5.1 Mechanical operation

Conditions: IEC 60512-9-1, Test 9a
 Speed: 10 mm/s maximum
 Rest: 1 s minimum (mated and unmated)
 250 operations

5.5.2 Insertion and withdrawal forces

Conditions: IEC 60512-13-2, Test 13b
 Speed: maximum rate of 12,5 mm per minute.
 All types, insertion and withdrawal: 20 N maximum

5.6 Transmission performance

5.6.1 General

Compliance to this document, in respect to transmission characteristics, shall be determined according to specific test methods described in test group FP. All transmission performance requirements shall apply between the reference planes specified in IEC 60512-26-100. All

transmission results shall be reported as worst case result for the corresponding pair or pair combination after testing all samples.

NOTE In the following subclauses f is the frequency, expressed in MHz.

5.6.2 Insertion loss

Conditions according to IEC 60512-26-100, test 26a

Mated connectors

All pairs: $\leq 0,04x\sqrt{f}$ dB from 1 MHz to 100 MHz.

Whenever the equation results in a value less than 0,1 dB, the requirement shall revert to 0,1 dB.

5.6.3 Return loss

Conditions according to IEC 60512-26-100, test 26b

Mated connectors

All pairs: $\geq 60-20\log(f)$ dB from 1 MHz to 100 MHz.

Whenever the equation results in a value greater than 30 dB, the requirement shall revert to 30 dB.

5.6.4 Near end cross talk

Conditions according to IEC 60512-26-100, test 26c

Mated connectors

All pair combinations: $\geq 83-20\log(f)$ dB from 1 MHz to 100 MHz.

Whenever the equation results in a value greater than 75 dB, the requirement shall revert to 75 dB.

5.6.5 Far end cross talk

Conditions according to IEC 60512-26-100, test 26d

Mated connectors

All pair combinations: $\geq 75,1-20\log(f)$ dB from 1 MHz to 100 MHz.

Whenever the equation results in a value greater than 75 dB, the requirement shall revert to 75 dB.

5.6.6 Transverse conversion loss

Conditions according to IEC 60512-26-100, test 26f

Mated connectors

All pairs: $\geq 66-20\log(f)$ dB from 1 MHz to 100 MHz.

Whenever the equation results in a value greater than 50 dB, the requirement shall revert to 50 dB.

5.6.7 Transfer conversion transfer loss

Conditions according to IEC 60512-26-100, test 26g

Mated connectors

All pairs: $\geq 66-20\log(f)$ dB from 1 MHz to 100 MHz.

TCTL at frequencies that correspond to calculated values of greater than 50 dB shall revert to a minimum requirement of 50 dB.

5.6.8 Transfer impedance

Conditions according to IEC 60512-26-100, test 26e

Mated connectors

All pairs: $\leq 0,1 x f^{0,3}$ Ω from 1 MHz to 10 MHz and $\leq 0,02 x f$ Ω from 10 MHz to 80 MHz.

6 Tests and test schedule

6.1 General

This clause states the test sequence (in accordance with this document) and the number of specimens for each test sequence.

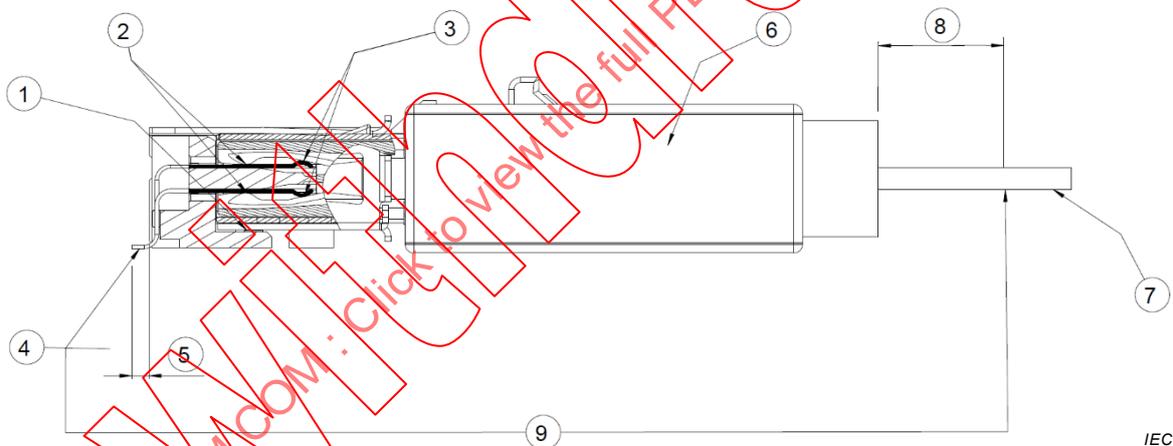
Individual variants may be submitted to type tests for approval of those particular variants.

Testers may limit the number of variants tested to a selection representative of the whole range for which approval is required (which may be less than the range covered by the detail specification), but each feature and characteristic shall be validated against the dimensional requirements and test sequences specified in this document.

The connectors shall have been processed in a careful and workmanlike manner, in accordance with good current practice.

Unless otherwise specified, mated sets of connectors shall be tested. For contact resistance measurements, care shall be taken to keep a particular combination of connectors together during the complete test sequence; that is, when un-mating is necessary for a certain test, the same connectors shall be mated for subsequent tests.

6.2 Arrangement for contact resistance test (Figure 8)



Key

- 1 Fixed connector
- 2 Point P1
- 3 Point P2
- 4 Point A. Measure the DC resistance across each of the 8 signal pins
- 5 As short as practical (except for vibration test EP5)
- 6 Free connector
- 7 Point C
- 8 As short as practical (except for vibration test EP5)
- 9 Contact resistance measurement points

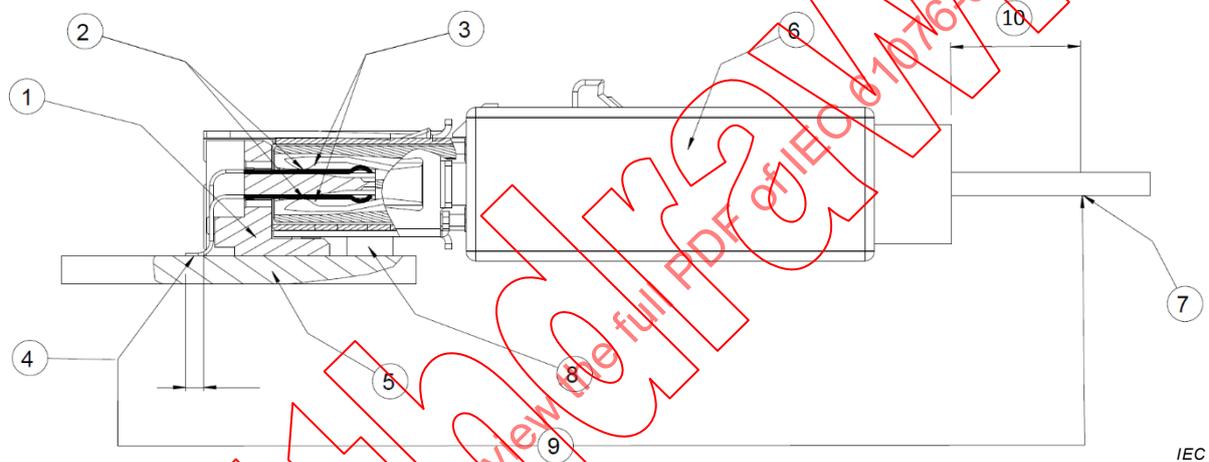
Figure 8 – Arrangement for contact resistance test

The test procedure is as follows:

- a) Determine the bulk resistance of the fixed connector between points A and P1 of Figure 9 by calculation or by measurement. This resistance is noted and recorded as R_{AP1} .
- b) Determine the bulk resistance of the free connector between points P2 and C of Figure 9 by calculation or by measurement. This resistance is noted and recorded as R_{CP2} .
- c) Measure the total mated connector resistance between points A and C, following the requirements and procedures of IEC 60512, Test 2a. This resistance is noted and recorded as R_{AC} .
- d) Calculate the contact resistance by subtracting the sum of the bulk resistance of the fixed and free connectors from the total mated connector resistance.

$$\text{Contact resistance} = R_{AC} - (R_{AP1} + R_{CP2})$$

6.3 Arrangement for vibration test (test phase DP3) (Figure 9)



Key

- 1 Fixed connector vibration feature
- 2 Not relevant for vibration testing
- 3 Not relevant for vibration testing
- 4 Point A: secure to the vibrating member, measure the DC resistance across each of the 8 signal pins
- 5 Mounting plate
- 6 Free connector
- 7 Point C: secure to the non-vibrating member.
- 8 Fixed connector rigidly fixed to the mounting plate
- 9 Contact resistance measurement point
- 10 Cable length ≥ 200 mm

Figure 9 – Arrangement for vibration test

6.4 Test procedures and measuring methods

The test methods specified and given in the relevant standards are the preferred methods, but not necessarily the only ones that can be used. In case of dispute, however, the specified method shall be used as the reference method.

Unless otherwise specified, all tests shall be carried out under standard atmospheric conditions for testing as specified in IEC 60068-1.

NOTE Where approval procedures are involved and alternative methods are employed, it is the responsibility of the manufacturer to satisfy the authority granting approval that any alternative methods which he may use give results equivalent to those obtained by the methods specified in this document.

6.5 Preconditioning

Before the tests are made, the connectors shall be preconditioned under standard atmospheric conditions for testing as specified in IEC 60068-1 for a period of 24 h, unless otherwise specified by the detail specification.

6.6 Test schedules

6.6.1 General

The test parameters required shall not be less than those listed in Clause 7.

6.6.2 Basic (minimum) test schedule

Not applicable.

6.6.3 Full test schedule

6.6.3.1 General

The following tests specify the characteristics which shall be checked and the requirements which shall be fulfilled.

For a complete test sequence, 21 specimens shall be used (Test groups AP, BP, DP, EP and FP shall each consist of 3 specimens. Test group CP consists of 6 specimens).

Contact resistance tests shall apply only to the interface.

6.6.3.2 Test group P – preliminary

All specimens shall be subjected to the following tests. All the test group specimens shall be subjected to the preliminary group P tests in the following sequence, see Table 9.

The specimens shall then be divided into the appropriate number of groups (Tables 10 to 15). All connectors in each group shall undergo the following tests as described in the sequence given.

Table 9 – Test group P

| Test phase | Test | | | Measurement to be performed | | |
|------------|---------------------|-------------------|---|------------------------------------|-------------------|--|
| | Title | IEC 60512 Test no | Severity or condition of test | Title | IEC 60512 Test no | Requirements |
| P1 | General examination | | | Visual examination | 1a | There shall be no defects that would impair normal operation |
| | | | | Examination of dimensions and mass | 1b | The dimensions shall comply with those specified in the detail specification |
| P2 | Contact resistance | | All contacts/ specimens | Low level contact resistance | 2a | Max. 80 mΩ initial, 100 mΩ final |
| P3 | | | 500 V d.c. 1 min hold | Insulation resistance | 3a | 500 MΩ minimum |
| P4 | | | Subject specimens to 500 V d.c. between adjacent contacts and 2 250 V d.c. between bridged signal contacts and earth shield | Voltage proof | 4a | No breakdown or flashover |

6.6.3.3 Test group AP – Climatic**Table 10 – Test group AP**

| Test phase | Test | | | Measurement to be performed | | |
|------------|--------------------------------|-------------------|---|-----------------------------|-------------------|--|
| | Title | IEC 60512 Test no | Severity or condition of test | Title | IEC 60512 Test no | Requirements |
| AP1 | Insertion and withdrawal force | | Measure the force necessary to insert / withdraw the specimens at a max. rate of 12,5 mm per minute (latching mechanism inactivated) | | 13b | 20 N max. for insertion and for withdrawal |
| AP2 | Rapid change of temperature | 11d | Subject mated specimens to 10 cycles between -55 °C and 85 °C with 30 min dwell at temp. extremes and 1 min transition between temperatures | | | Meet visual requirements, show no physical damage. |
| AP3 | | | Subject specimens to 500 V d.c. between adjacent contacts and 2 250 V d.c. between bridged signal contacts and earth shield | Voltage proof | 4a | No breakdown or flashover |
| AP4 | | | 500 V d.c., 1 min hold | Insulation resistance | 3a | 500 MΩ minimum |
| AP5 | | | All contacts/ specimens | Contact resistance | 2a | 80 mΩ max. |

| Test phase | Test | | | Measurement to be performed | | |
|------------|--|-------------------|--|------------------------------|---------------------------|--|
| | Title | IEC 60512 Test no | Severity or condition of test | Title | IEC 60512 Test no | Requirements |
| AP6 | Dry heat | 11i | Subject mated specimens to a temperature of 85 °C during 21 days | | | Meet visual requirements, show no physical damage. |
| AP7 | Humidity/temperature cycling | | Subject mated specimens to 10 cycles (10 days) between 25 °C and 60 °C at 80 % to 100 % RH | | IEC 60068-2-38, test Z/AD | Meet visual requirements, show no physical damage. |
| AP8 | Cold | 11j | Subject mated samples to a temperature of -55 °C for 10 days | | | Meet visual requirements, show no physical damage. |
| AP9 | Contact resistance | | All contacts/specimens | Low level contact resistance | 2a | 100 mΩ max. |
| AP10 | | | Subject specimens to 500 V d.c. between adjacent contacts and 2 250 V d.c. between bridged signal contacts and earth shield | Voltage proof | 4a | No breakdown or flashover |
| AP11 | | | 500 V d.c., 1 min hold | Insulation resistance | 3a | 500 MΩ minimum |
| AP12 | Insertion and withdrawal force | | Measure the force necessary to insert / withdraw the specimens at a max. rate of 12.5 mm per minute (latching mechanism inactivated) | | 13b | 20 N max. for insertion and for withdrawal |
| AP13 | Effectiveness of connector coupling device | 15f | Rate of load application 45 N/s maximum. | | | 50 N for 60 s ± 5 s. |
| AP14 | General examination | | | Visual examination | 1a | There shall be no defects that would impair normal operation |